Notice of References Cited Application/Control No. | Applicant(s)/Patent Under Reexamination | KITAZAWA, AKITOSHI | Examiner | Art Unit | Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0007906 A1	01-2004	Park et al.	297/217.3
*	В	US-6,351,705	02-2002	Yoshioka, Kazunori	701/200
*	O	US-2002/0175564	11-2002	Tengler et al.	307/9.1
*	۵	US-2003/0007227	01-2003	Ogino, Takayuki	359/227
*	Е	US-6,029,110	02-2000	Zuber et al.	701/200
*	F	US-5,191,312	03-1993	Altmann et al.	340/441
*	G	US-5,541,572	07-1996	Okamoto et al.	340/438
*	Ι	US-2004/0121645	06-2004	Postrel, Richard	439/374
	_	US-			
	J	US-			
	Κ	US-			
	٦	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	z	JP 02124683 A	05-1990	Japan	SEKIGUCHI, TSUTOMU	
	0	JP 10116086 A	05-1998	Japan	KUBOTA et al.	
	Р					
	α					
	R					
	S					
	Τ					

NON-PATENT DOCUMENTS

_	NON-FATENT DOCUMENTS						
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	U						
	V		,				
	w		_				
	x						

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.